Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,937	HAYASHI ET AL.	
Examiner	Art Unit	
Chi Q. Nguyen	3635	

SEARCHED			
Class	Subclass	Date	Examiner
52	300	9/24/2007	CN
74	552	9/24/2007	CN
74	558	9/24/2007	CN
74	558.5	9/24/2007	CN
29	894.1	9/24/2007	CN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PALM inventor name	9/20/2007	CN
BRS search	9/20/2007	CN
search related art	9/20/2007	CN